STY130NF20D



N-channel 200 V, 0.01 Ω typ., 130 A STripFET™ II with fast recovery diode Power MOSFET in a Max247 package

Datasheet - production data

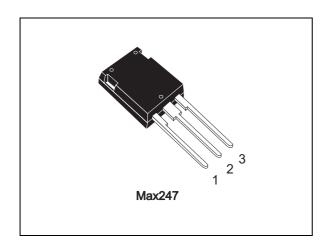
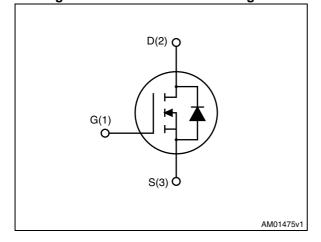


Figure 1. Internal schematic diagram



Features

| Order code | V _{DS} | R _{DS(on)} max. | I _D | P _{TOT} |
|-------------|-----------------|-----------------------------|----------------|------------------|
| STY130NF20D | 200 V | 0.012 Ω | 130 A | 450 W |

- Exceptional dv/dt capability
- 100% avalanche tested
- · Low gate charge

Applications

Switching applications

Description

This Power MOSFET is produced using STMicroelectronics' unique STripFET™ process, which is specifically designed to minimize input capacitance and gate charge. The device offers extremely fast switching performance thanks to the intrinsic fast body diode, making the device ideal for hard switching topologies.

Table 1. Device summary

| Order code | Marking | Packages | Packaging |
|-------------|----------|----------|-----------|
| STY130NF20D | 130NF20D | Max247 | Tube |

Contents STY130NF20D

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STY130NF20D Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|------------------------------------|---|-------------|------|
| V _{GS} | Gate-source voltage | ± 20 | V |
| I _D | Drain current (continuous) at T _C = 25 °C | 130 | Α |
| I _D | Drain current (continuous) at T _C =100 °C | 82 | Α |
| I _{DM} ⁽¹⁾ | Drain current (pulsed) | 520 | Α |
| P _{TOT} | Total dissipation at T _C = 25 °C | 450 | W |
| I _{AR} (1) | Avalanche current, repetitive or not repetitive | 130 | Α |
| E _{AS} | Single pulse avalanche energy (2) | 800 | mJ |
| dv/dt ⁽³⁾ | Peak diode recovery voltage slope | 25 | V/ns |
| T _J T _{stg} | Operating junction temperature Storage temperature | - 55 to 150 | °C |

^{1.} Pulse width limited by T_{jmax}

Table 3. Thermal resistance

| Symbol | Parameter | Value | Unit |
|--|--|-------|------|
| R _{thj-case} Thermal resistance junction-case | | 0.28 | °C/W |
| R _{thj-amb} | R _{thj-amb} Thermal resistance junction-ambient | | °C/W |

^{2.} Starting T_j = 25 °C, I_D = I_{AR} , V_{DD} = 50 V

^{3.} $I_{SD} \leq 130 \text{ A, di/dt} \leq 1000 \text{ A/}\mu\text{s, peak } V_{DS} \leq V_{(BR)DSS}$

Electrical characteristics STY130NF20D

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|----------------------|------------------------------------|--|------|------|-------|------|
| V _{(BR)DSS} | Drain-source breakdown voltage | V _{GS} = 0, I _D = 1 mA | 200 | | | V |
| | Zero gate voltage drain | V _{GS} = 0, V _{DS} = 200 V | | | 10 | μΑ |
| I _{DSS} | current | V _{GS} = 0, V _{DS} =200 V, T _C =125 °C | | | 100 | μΑ |
| I _{GSS} | Gate body leakage current | $V_{DS} = 0, V_{GS} = \pm 20 \text{ V}$ | | | ±100 | nA |
| V _{GS(th)} | Gate threshold voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | 2 | 3 | 4 | V |
| R _{DS(on)} | Static drain-source on- resistance | V _{GS} = 10 V, I _D = 65 A | | 0.01 | 0.012 | Ω |

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|-----------------------------------|---------------------------------------|--|------|-------|------|------|
| C _{iss} | Input capacitance | | - | 11100 | - | pF |
| C _{oss} | Output capacitance | $V_{GS}=0, V_{DS}=25 V,$ | - | 2190 | - | pF |
| C _{rss} | Reverse transfer capacitance | f=1 MHz, | - | 334 | - | pF |
| C _{o(tr)} ⁽¹⁾ | Equivalent capacitance time related | V _{GS} =0, V _{DS} = o to 160 | - | 1525 | - | pF |
| C _{o(er)} ⁽²⁾ | Equivalent capacitance energy related | | - | 1139 | - | pF |
| R _G | Intrinsic gate resistance | f=1 MHz, I _D =0 | - | 1.4 | - | Ω |
| Q_g | Total gate charge | V _{DD} =160 V, I _D = 130 A V _{GS} = 10 V | - | 338 | - | nC |
| Q _{gs} | Gate-source charge | | - | 47 | - | nC |
| Q _{gd} | Gate-drain charge | (see Figure 16) | - | 183 | - | nC |

^{1.} $C_{o(er)}$ is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}

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^{2.} $C_{o(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}

Table 6. Switching times

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|---------------------|---------------------|--|------|------|------|------|
| t _{d(on)} | Turn-on delay time | | - | 232 | - | ns |
| t _r | Rise time | $V_{DD} = 100 \text{ V}, I_{D} = 65 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ | - | 218 | - | ns |
| t _{d(off)} | Turn-off delay time | $G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 15) | - | 283 | - | ns |
| t _f | Fall time | | - | 250 | - | ns |

Table 7. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|---------------------------------|--|--------------------------------------|------|------|------|---------|
| I _{SD} | Source-drain current | | - | | 130 | Α |
| I _{SDM} ⁽¹⁾ | Source-drain current (pulsed) | | - | | 520 | Α |
| V _{SD} ⁽²⁾ | Forward on voltage I _{SD} = 130 A, V _{GS} =0 | | - | | 1.6 | V |
| t _{rr} | Reverse recovery time | I _{SD} = 130 A, | - | 190 | | ns |
| Q _{rr} | Reverse recovery charge | $di/dt = 100 A/\mu s$, | - | 1.4 | | μ C |
| I _{RRM} | Reverse recovery current | V _{DD} = 100 V | - | 14 | | Α |
| t _{rr} | Reverse recovery time | I _{SD} = 130 A, | - | 257 | | ns |
| Q _{rr} | Reverse recovery charge | $di/dt = 100 \text{ A}/\mu\text{s},$ | - | 2.4 | | μ C |
| I _{RRM} | Reverse recovery current | V _{DD} = 100 V, Tj=150 °C | - | 18 | | Α |

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration= 300μ s, duty cycle 1.5%

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2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

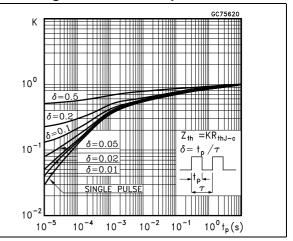
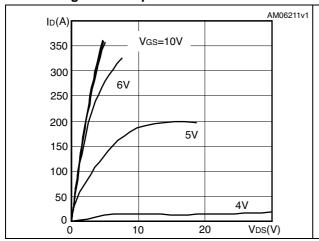


Figure 4. Output characteristics

100

V_{DS}(V)

Figure 5. Transfer characteristics



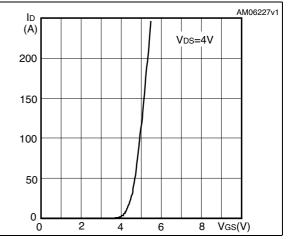
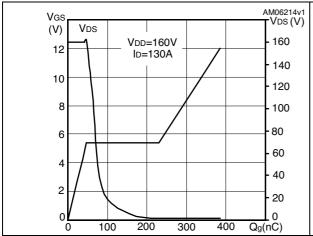
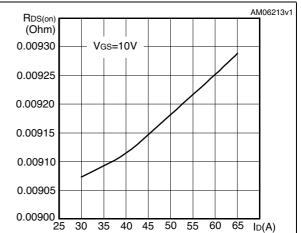


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance





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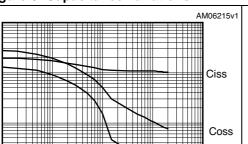
C (pF)

10000

1000

100

Figure 8. Capacitance variations



Crss

VDS(V)

100

Figure 9. Output capacitance stored energy

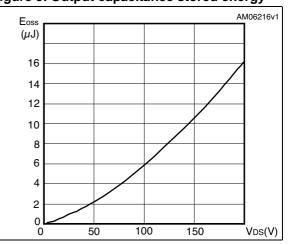
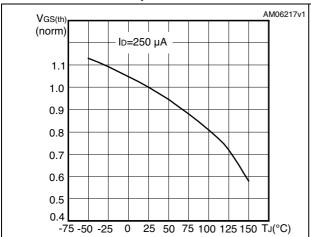


Figure 10. Normalized gate threshold voltage vs temperature

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Figure 11. Normalized on-resistance vs temperature



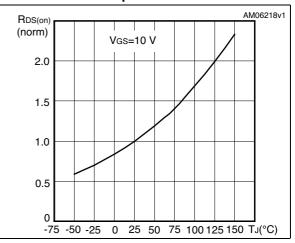
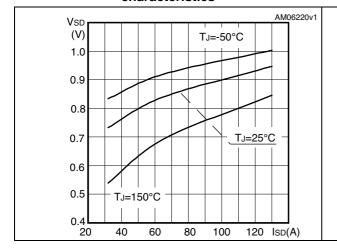
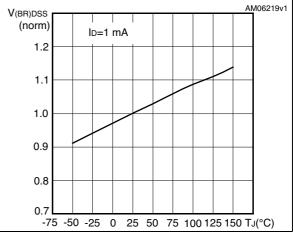


Figure 12. Source-drain diode forward characteristics

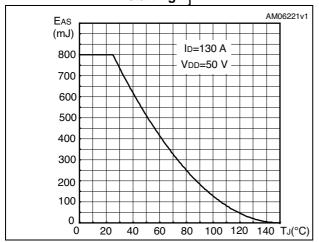
Figure 13. Normalized $V_{(BR)DSS}$ vs temperature





Electrical characteristics STY130NF20D

Figure 14. Maximum avalanche energy vs starting $\mathbf{T}_{\mathbf{j}}$



STY130NF20D Test circuit

3 Test circuit

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

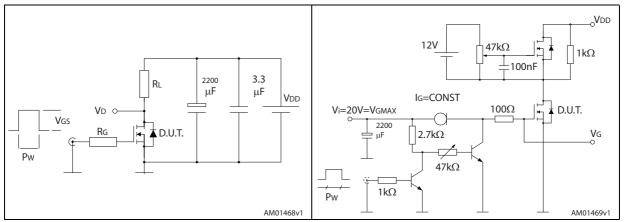


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

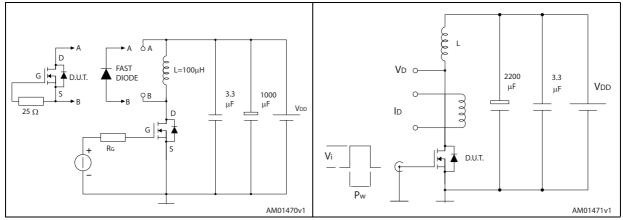
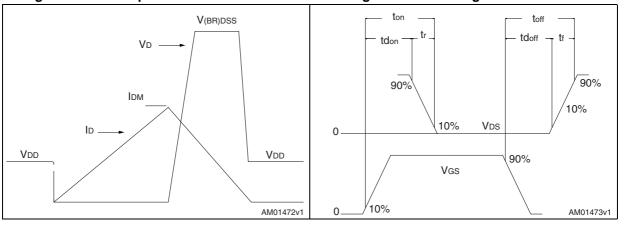


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



DIMENSIONS IN mm HEAT-SINK PLANE Gate D A1 *b1* b2 BACK VIEW 0094330_Rev_D

Figure 21. Max247 drawing

Table 8. Max247 mechanical data

| Dim. | | mm | | | | |
|--------|-------|------|-------|--|--|--|
| Dilli. | Min. | Тур. | Max. | | | |
| А | 4.70 | | 5.30 | | | |
| A1 | 2.20 | | 2.60 | | | |
| b | 1.00 | | 1.40 | | | |
| b1 | 2.00 | | 2.40 | | | |
| b2 | 3.00 | | 3.40 | | | |
| С | 0.40 | | 0.80 | | | |
| D | 19.70 | | 20.30 | | | |
| е | 5.35 | | 5.55 | | | |
| Е | 15.30 | | 15.90 | | | |
| L | 14.20 | | 15.20 | | | |
| L1 | 3.70 | | 4.30 | | | |

STY130NF20D Revision history

5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 27-Jan-2009 | 1 | First release |
| 29-Oct-2009 | 2 | Some values have been updated in <i>Table 4</i> , <i>Table 5</i> , <i>Table 6</i> and <i>Table 7</i> |
| 11-Jan-2010 | 3 | Document status promoted from preliminary data to datasheet. |
| 16-May-2014 | 4 | Modified: title Modified: Figure 5, 6, 10, 11 and 13 Minor text changes in the cover page. |

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